

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	
	:	Examiner: AKS Liew
TAKAAKI ENDO ET AL.	)	
	:	Art Unit: 2624
Application No.: 10/721,875	)	
	:	Conf. No.: 6094
Filed: November 26, 2003	)	
	:	
For: IMAGE PROCESSING METHOD	)	
AND APPARATUS FOR	:	
GENERATING PANORAMIC	)	
IMAGE	:	May 17, 2007

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

THIRD  
INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

The listed documents were cited in an Office Action issued in connection with the Japanese counterpart of this application, and a copy of that Office Action also is enclosed.

For the concise statement of relevance of the cited documents, the Examiner is respectfully referred to the accompanying English abstracts, and to the partial translation provided for JPA11-234501, which is a translation of the portion of that document specifically relied upon by the Japanese Examiner..

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

/Leonard P Diana/  
Leonard P. Diana  
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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>00862.023325</b>		APPLICATION NO. <b>10/721,875</b>	
APPLICANTS <b>TAKAAKI ENDO ET AL.</b>				FILING DATE <b>November 26, 2003</b>		GROUP <b>2624</b>	

  

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)

  

FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
	JPA	11-234501	08/27/99	Japan	H04N	1/387	
	JPA	11-289447	10/19/99	Japan	H04N	1/387	

  

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)		

  

EXAMINER	DATE CONSIDERED
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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